

Spatial Statistics

Point Process Data Unit 3

PM569 Spatial Statistics

Lecture 10: November 11, 2016

Review of point processes

- ▶ Testing for CSR:
 - ▶ Adjusting for edge effect
 - ▶ Testing for CSR with Ripley's K .
 - ▶ Testing for CSR based on inter-event distances, $H(h)$.
 - ▶ Testing for CSR based on nearest-neighbour distances, $G(h)$.
- ▶ Spatial processes, Poisson processes are the building block:
 - ▶ Homogeneous Poisson process (constant intensity).
 - ▶ Inhomogeneous Poisson process (intensity varies across domain).
 - ▶ Poisson Cluster process (intensity varies for parents and/or children forming clusters), Cox process when the cluster intensity is spatially varying.
 - ▶ Simple inhibition processes, Markovian processes (Strauss and pairwise interaction) for regular patterns.
- ▶ In this lecture we will focus on fitting point process models and on methods for detecting clusters.

Fitting point process models

- ▶ Given our set of observed point events $\{x_1, \dots, x_n\}$ in region A we wish to fit a model (which is stationary and isotropic)
- ▶ Model fitting is approached by estimating the parameters of the particular process
 - ▶ Example: fitting the parameters ρ , μ and σ^2 of a clustered process
 - ▶ Example: fitting a parametric form of the intensity of an inhomogeneous poisson process
- ▶ We use familiar fitting methods: Least squares, Maximum Likelihood and non-parametric methods.

Fitting point process models: Least Squares

- ▶ We start with $K(h)$ and the estimator $\hat{K}(h)$ (or L, or G, or H) for parameter fitting
- ▶ This is useful when the mathematical form of $K(h)$ is known either explicitly or as an integral (which is true for some point processes)
- ▶ If $K(h)$ is not known we use the simulated realizations
- ▶ Example, to fit a homogeneous poisson cluster process we have parameters $\theta = (\rho, \sigma)$ and the Ripley's K function is:

$$K(h, \theta) = \pi h^2 + \frac{1}{\rho}(1 - \exp(-h^2/(4\sigma^2)))$$

- ▶ And we estimate $\hat{K}(h)$ from the data

Fitting point process models: Least Squares

- ▶ Given the theoretical K-function and the estimator $\hat{K}(h)$ we minimize the deviance:

$$D(\theta) = \int_0^{h_0} [(\hat{K}(h))^c - (K(h, \theta))^c]^2 dh$$

- ▶ Where h_0 is the maximum distance which is typically chosen as 1/3 to 1/2 of the width of a rectangular region, and c is the power transformation
- ▶ The power transformation controls the sampling fluctuations in $\hat{K}(h)$ which can increase with h and have influence on $\hat{\theta}$ (i.e. it is a variance stabilizer)
- ▶ Examples of c are $c=0.5$ for a pattern that is not too different from CSR, $c=0.25$ for cluster patterns. However, choose a variety of c values in practice in order to see how sensitive the results are

Fitting point process models: Least Squares Estimation Steps

1. Compute the edge corrected $\hat{K}(h)$

$$\hat{K}(h) = \frac{|A|}{n^2} \sum_{i=1}^n \sum_{j \neq i} I(h_{i,j} \leq h)$$

2. Choose a theoretical model for $K(h, \theta)$ where θ are the parameters of the model
3. Find $\hat{\theta}$ that minimizes the deviance for a given c

$$D(\theta) = \int_0^{h_0} [(\hat{K}(h))^c - (K(h, \theta))^c]^2 dh$$

Fitting point process models: Least Squares Estimation

- ▶ When $K(h, \theta)$ is unknown because there is no closed form, use the simulated method (for s simulations):

$$\bar{K}_s(h, \theta) = \frac{1}{n} \sum_{i=1}^s \hat{K}_i(h, \theta)$$

- ▶ Finding $\bar{K}_s(h, \theta)$ for each value of θ can be prohibitive computationally
 1. Start with a small number of simulations, s
 2. Find a first approximation of $\hat{\theta}$
 3. Repeat with a larger value for s

Fitting point process models: Least Squares Estimation Steps

- ▶ A weighted version of the deviance, shown to have asymptotic properties (consistency and asymptotic normality), is often used:

$$D(\theta) = \int_0^{h_0} w(h) [(\hat{K}(h))^c - (K(h, \theta))^c]^2 dh$$

- ▶ The weight $w(h)$ is a weight on the distance also controls the variance
- ▶ When $c = 0.5$ and $w(h) = 1$ we have the Poisson cluster process
- ▶ See Guan and Sherman, J R Stat Soc (2007) for asymptotic properties

Fitting point process models: Least Squares Estimation

- ▶ In R `spatstat`, cluster or Cox point process models are fit with least squares estimation through the `kppm` function with the `method="mincontrast"` option
- ▶ To fit a log-Gaussian Cox point process, use the function `lgcp.estK`
- ▶ To fit the Matern cluster process (type I or II), use the function `matclust.estK`

Fitting point process models: Maximum Likelihood

- ▶ To fit inhomogeneous Poisson, Strauss and pairwise interaction processes we need to rely on likelihood methods
- ▶ Recall for the inhomogeneous Poisson process:
 - ▶ $N(A)$ is Poisson with mean $\int_A \lambda(x)dx$
 - ▶ Conditional on $N(A) = n$, the n events in A form an independent random sample from A with a probability distribution function proportional to $\lambda(x)$
- ▶ We can define the process based on its conditional intensity
- ▶ Namely, the conditional probability of finding a point of the process inside an infinitesimal neighbourhood du of the location u given the complete point pattern \mathbf{x} is $\lambda(u, \mathbf{x})du$

Fitting point process models: Conditional Intensity

- ▶ For example, CSR has conditional intensity $\lambda(u, \mathbf{x}) = \lambda$
- ▶ The IPP has conditional intensity $\lambda(u, \mathbf{x}) = \lambda(u)$
- ▶ Sometimes the IPP trend is denoted as $\beta(u)$ and indicates "spatial trend"
- ▶ The Strauss process has conditional intensity $\lambda(u, \mathbf{x}) = \beta^n \gamma^p$ where β is the intensity, γ is the interaction parameter, and p is the number of points of \mathbf{x} that lie within a distance δ of u (i.e. pairs of neighbours)
- ▶ For example, the Strauss process with $\gamma < 1$ dependence between points is reflected in the fact that the conditional probability of finding a point of the process at the location u is reduced if other points of the process are present within a distance δ . And when $\gamma = 0$, the conditional probability of finding a point at u is zero if there are any other points of the process within a distance δ of this location.

Fitting point process models: Pseudolikelihood

- ▶ Because maximum likelihood is difficult for point process models, the log of the pseudolikelihood is maximized, using the conditional intensity
- ▶ For a point process governed by parameter θ the pseudolikelihood is:

$$PL(\theta; x) = \prod_{i=1}^n \lambda_{\theta}(x_i; x) \exp\left(\int_A \lambda_{\theta}(u; x) du\right)$$

- ▶ The maximum pseudolikelihood estimate of θ minimizes the above equation

Fitting point process models: Pseudolikelihood

- ▶ We need to take the log of the pseudolikelihood equation and approximate the integral using a "quadrature" scheme (see Berman and Turner, 1992)

$$\int_A \lambda_\theta(u; x) du \approx \sum_{j=1}^m \lambda_\theta(u_j, x) w_j$$

- ▶ Where u_j are "quadrature points" in A and $w_j \geq 0$ are the "quadrature weights"

Fitting point process models: Pseudolikelihood

- ▶ The quadrature points can be chosen as all data points, x_i and the addition of some dummy points u_j , i.e.
 $\{x_1, \dots, x_n\} \subset \{u_1, \dots, u_m\}$
- ▶ Then the log pseudolikelihood can be written:

$$\log PL(\theta; x) = \sum_{j=1}^m z_j \log \lambda_{\theta}(u_j; x) - w_j \lambda_{\theta}(u_j; x)$$

- ▶ Where $z_j = 1$ if u_j is a data point, and $z_j = 0$ if u_j is a dummy point

Fitting point process models in R

- ▶ In R spatstat the function ppm fits models by pseudolikelihood based on the conditional intensity $\lambda_{\theta}(u, x)$
- ▶ The model must be loglinear in the parameters θ
- ▶ For example, the Strauss process can be written:

$$\log \lambda(u, x) = \log \beta + \log \gamma p$$

- ▶ So $\theta = (\log \beta, \log \gamma)$ are the "regular parameters" and the parameter driving the interaction, p is the "irregular parameter"

Fitting point process models in R

- ▶ Thus in spatstat ppm the conditional intensity is split into first and higher order terms:

$$\log \lambda_{\theta}(u, x) = \eta S(u) + \phi V(u, x)$$

- ▶ The first order term $S(u)$ describes the spatial inhomogeneity of the intensity (including covariate effects) and the higher order term $V(u, x)$ describes the interactions between points

Fitting point process models in R

- ▶ The general form of ppm is `ppm(X, trend, interaction, ...)`
- ▶ The trend argument specifies any spatial trend or covariate effects and is written as an R formula
- ▶ The default trend formula is ~ 1 , which indicates $\lambda(u) = 1$, corresponding to a process without spatial trend or covariate effects. The formula $\sim x$ indicates the vector statistic $\lambda(x, y) = (1, x)$ corresponding to a spatial trend of the form $\exp(\alpha + \beta x)$, where α, β are coefficient parameters to be estimated, while $\sim x + y$ indicates $\lambda(x, y) = (1, x, y)$ corresponding to $\exp(\alpha + \beta x + \gamma y)$

Fitting point process models in R

- ▶ The general form of ppm is `ppm(X, trend, interaction,...)`
- ▶ The interaction term represents the interaction function $V(u, x)$
- ▶ For example, the Strauss function with interaction distance $\delta = 0.1$ is fit with `ppm(X, 1, Strauss(r=0.1))`
- ▶ Note that the ppm with a specified higher order term calls the first order term for the intensity β rather than λ
- ▶ `spatstat` automatically creates a quadrature scheme but it can be controlled by the user through the function `quadscheme`

Point Pattern Data: Detecting Clusters

- ▶ So far we have simulated point processes, found statistics that indicate a global measure of what pattern there may be, and fit models to specific types of point patterns.
- ▶ If we want to find where clusters of observations are located, we need a different set of tools called scan statistics.
- ▶ Goals of scan statistics:
 - ▶ To determine areas where the number of events is inconsistent with the number observed over the rest of the study area.
 - ▶ Compare local rates of events (or case/control ratios) to detect clusters.

Point Pattern Data: Detecting Clusters

- ▶ First attempts at cluster detection methods were developed in the 1980s: geographical analysis machine and the cluster evaluation permutation procedure.
- ▶ Early cluster detection methods:
 - ▶ Graphical in nature
 - ▶ Divides the region up into a fine grid
 - ▶ Uses a search window, which is a circle of predefined radius, larger than the grid spacing in order for circles to overlap
 - ▶ Centers the circle over each grid cell, then moves across the region
 - ▶ The number of cases occurring within the search window are counted
 - ▶ The circle is drawn on the map if the count observed within the circle exceeds some tolerance level
 - ▶ The tolerance level may be defined as the observed count exceeding all of the counts associated with that circle under random selection ($N=499$)

Point Pattern Data: Detecting Clusters

- ▶ The circle in these cases is considered a circular uniform kernel
- ▶ In kernel estimation, the kernel is centered on the data locations, in scan statistics, the circle is centered on the grid

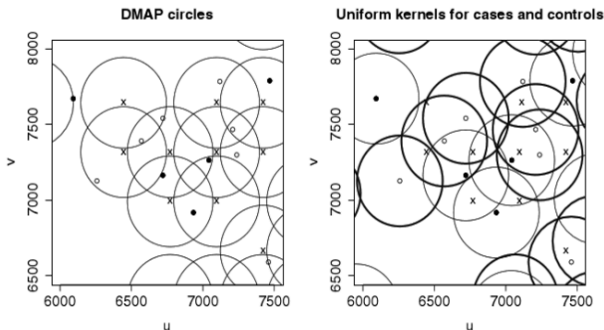


FIG. 6.8 Equivalence between the case/control ratio within circles surrounding grid points (left-hand plot) and the ratio of intensity (density) functions based on circular uniform kernels (right-hand plot). Case locations appear as filled small circles, control locations as open small circles, and grid points as “x” symbols. In the left-hand plot, large circles represent radii of 300 units around each grid point. In the right-hand plot, dark circles represent control kernel radii, and lighter circles represent control kernel radii (both 300 units).

Point Pattern Data: Spatial Scan Statistics

- ▶ A scan statistics involves the definition of a moving window and a statistical comparison measurement (count or rate) within the window to the same measurement outside the window.
- ▶ Kulldorff (1995, 1997) defines a spatial scan statistic that is similar to the geographical analysis machine, but with an inferential framework.
- ▶ Scan statistics tend to consider circular windows with variable radii ranging from the smallest distance between a pair of cases to the user-defined upper bound.
- ▶ The circles can be centered on either grid locations (like earlier methods) or the set of locations. Different results will be seen depending on what is chosen.

Point Pattern Data: Spatial Scan Statistics

Setup:

Let $N_{1,in}$ represent the number of case locations and $N_{in} = N_{0,in} + N_{1,in}$ be the total number of people at risk (or number of case and control locations) inside a particular window.

Let $N_{1,out}$ represent the number of case locations and $N_{out} = N_{0,out} + N_{1,out}$ be the total number of people at risk (or number of case and control locations) outside the window.

The test statistic is:

$$T_{scan} = \max \left(\frac{N_{1,in}}{N_{in}} \right)^{N_{1,in}} \left(\frac{N_{1,out}}{N_{out}} \right)^{N_{1,out}} I \left(\frac{N_{1,in}}{N_{in}} > \frac{N_{1,out}}{N_{out}} \right)$$

$I(\cdot)$ is the indicator function (i.e. we only maximize over windows where the observed rate inside the window exceeds that outside the window)

Point Pattern Data: Spatial Scan Statistics

- ▶ The maximum observed likelihood ratio statistic provides a test of overall general clustering and an indication of the most likely clusters with significance determined by Monte Carlo testing of the constant risk hypothesis.
- ▶ SaTScan is a software package that enables this, and we can access it through R `satscan` (both must be downloaded).